Issue	Classification

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,633	WASHINGTON ET AL.
Examiner	Art Unit
Staven & Baile	2076

Steven S. Paik 2876	l			
Geven e. Faik 2070				
ISSUE CLASSIFICATION				
ORIGINAL CROSS REFERENCE(S)				
CLASS SUBCLASS CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)				
235 379 235 435 381				
INTERNATIONAL CLASSIFICATION 271 145				
G 0 7 F 19/00				
/				
(Assistant Examiner) (Date)	ms Allowed: 27			
Steven S. Paik 8/2/06 O.G. Print Claim(O.G. n(s) Print Fig.			
(Legal Instruments Examiner) (Date) (Primary Examiner) (Date)	19			
☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D.	☐ R.1.47			
E E	182 183 184 185 186 187 188 188 189 190 191 192 193			
14 44 74 104 134 164 15 2 45 75 105 135 165				